

**MJ8504**  
**MJ8505**

**Designers Data Sheet**

**SWITCHMODE SERIES**  
**NPN SILICON POWER TRANSISTORS**

The MJ8504 and MJ8505 transistors are designed for high-voltage, high-speed, power switching in inductive circuits where fall time is critical. They are particularly suited for line operated switch-mode applications such as:

- Switching Regulators
- Inverters
- Solenoid and Relay Drivers
- Motor Controls
- Deflection Circuits

**Fast Turn-Off Times**

- 75 ns Inductive Fall Time -25°C (typ)
- 150 ns Inductive Crossover Time -25°C (typ)
- 1.25 μs Inductive Storage Time -25°C (typ)

Operating Temperature Range -65 to +200°C

100°C Performance Specified for:

- Reverse-Biased SOA with Inductive Loads
- Switching Times with Inductive Loads
- Saturation Voltages
- Leakage Currents

**MAXIMUM RATINGS**

Rating	Symbol	MJ8504	MJ8505	Unit
Collector-Emitter Voltage	V <sub>CEO(sus)</sub>	700	800	Vdc
Collector-Emitter Voltage	V <sub>CEV</sub>	1200	1400	Vdc
Emitter Base Voltage	V <sub>EB</sub>	8.0	8.0	Vdc
Collector Current - Continuous	I <sub>C</sub>	10	10	Adc
Peak (1)	I <sub>CM</sub>	15	15	
Base Current - Continuous	I <sub>B</sub>	8	8	Adc
Peak (1)	I <sub>BM</sub>	12	12	
Total Power Dissipation @ T <sub>C</sub> = 25°C	P <sub>D</sub>	175	175	Watts
@ T <sub>C</sub> = 100°C		100	100	
Derate above 25°C		1.0	1.0	W/°C
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-65 to +200		°C

**THERMAL CHARACTERISTICS**

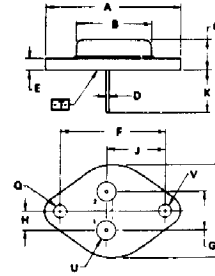
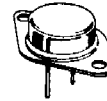
Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	R <sub>θJC</sub>	1.0	°C/W
Maximum Lead Temperature for Soldering	T <sub>L</sub>	275	°C
Purposes: 1/8" from Case for 5 Seconds			

(1) Pulse Test: Pulse Width = 5 ms, Duty Cycle < 10%.

**10 AMPERE**  
**NPN SILICON**  
**POWER TRANSISTORS**  
700 and 800 VOLTS  
175 WATTS

**Designer's Data for**  
**"Worst Case" Conditions**

The Designers Data Sheet permits the design of most circuits entirely from the information presented. Limit data - representing device characteristics boundaries are given to facilitate "worst case" design.



NOTES:  
1. DIMENSIONS D AND V ARE DATUMS  
2. T IS SEATING PLANE AND DATUM  
3. POSITIONAL TOLERANCE FOR MOUNTING HOLE G  
4. DIMENSIONS AND TOLERANCES PER ANSI Y14.5, 1973.

DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	-	39.37	-	1.550
B	-	21.08	-	0.830
C	6.35	7.62	0.250	0.300
D	0.87	1.09	0.034	0.043
E	-	3.43	-	0.135
F	30.15 BSC	1.87 BSC		
G	10.92 BSC	0.430 BSC		
H	5.46 BSC	0.215 BSC		
J	16.80 BSC	0.665 BSC		
K	11.18	12.19	0.440	0.480
L	3.81	4.19	0.150	0.165
M	-	26.67	-	1.050
N	4.83	5.33	0.190	0.210
O	3.81	4.19	0.150	0.165

STYLE 1  
PIN 1. BASE  
2. EMITTER  
CASE. COLLECTOR

TO-3



# New Jersey Semi-Conductor Products, Inc.

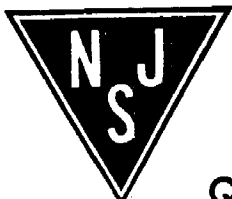
20 STERN AVE.  
SPRINGFIELD, NEW JERSEY 07081  
U.S.A.

TELEPHONE: (201) 376-2922  
(212) 227-6005  
FAX: (201) 376-8960

## ELECTRICAL CHARACTERISTICS ( $T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit	
<b>OFF CHARACTERISTICS</b>						
Collector-Emitter Sustaining Voltage (Table 1) ( $I_C = 100\text{ mA}$ , $I_B = 0$ )	MJ8504 MJ8505	$V_{CE0(sus)}$	700 800	— —	— —	Vdc
Collector Cutoff Current ( $V_{CEV} = \text{Rated Value}$ , $V_{BE(off)} = 1.5\text{ Vdc}$ ) ( $V_{CEV} = \text{Rated Value}$ , $V_{BE(off)} = 1.5\text{ Vdc}$ , $T_C = 150^\circ\text{C}$ )		$I_{CEV}$	— —	— —	0.25 5.0	mAdc
Collector Cutoff Current ( $V_{CE} = \text{Rated } V_{CEV}$ , $R_{BE} = 50\ \Omega$ , $T_C = 100^\circ\text{C}$ )		$I_{CER}$	—	—	5.0	mAdc
Emitter Cutoff Current ( $V_{EB} = 7.0\text{ Vdc}$ , $I_C = 0$ )		$I_{EBO}$	—	—	1.0	mAdc
<b>SECOND BREAKDOWN</b>						
Second Breakdown Collector Current with base forward biased		$I_{S/b}$	See Figure 12			
Clamped Inductive SOA with Base Reverse Biased		RBSOA	See Figure 13			
<b>ON CHARACTERISTICS (1)</b>						
DC Current Gain ( $I_C = 1.5\text{ Adc}$ , $V_{CE} = 5.0\text{ Vdc}$ )		$h_{FE}$	7.5	—	—	—
Collector-Emitter Saturation Voltage ( $I_C = 5.0\text{ Adc}$ , $I_B = 2.0\text{ Adc}$ ) ( $I_C = 10\text{ Adc}$ , $I_B = 4.0\text{ Adc}$ ) ( $I_C = 5.0\text{ Adc}$ , $I_B = 2.0\text{ Adc}$ , $T_C = 100^\circ\text{C}$ )		$V_{CE(sat)}$	— — —	— — —	2.0 5.0 3.0	Vdc
Base-Emitter Saturation Voltage ( $I_C = 5.0\text{ Adc}$ , $I_B = 2.0\text{ Adc}$ ) ( $I_C = 5.0\text{ Adc}$ , $I_B = 2.0\text{ Adc}$ , $T_C = 100^\circ\text{C}$ )		$V_{BE(sat)}$	— —	— —	1.5 1.5	Vdc
<b>DYNAMIC CHARACTERISTICS</b>						
Output Capacitance ( $V_{CB} = 10\text{ Vdc}$ , $I_E = 0$ , $f_{test} = 1.0\text{ kHz}$ )		$C_{ob}$	90	—	450	pF
<b>SWITCHING CHARACTERISTICS</b>						
Resistive Load (Table 1)						
Delay Time	$(V_{CC} = 500\text{ Vdc}$ , $I_C = 5.0\text{ A}$ , $I_{B1} = 2.0\text{ A}$ , $V_{BE(off)} = 5.0\text{ Vdc}$ , $t_p = 50\ \mu\text{s}$ , Duty Cycle $< 2.0\%$ )	$t_d$	—	0.050	0.20	$\mu\text{s}$
Rise Time		$t_r$	—	0.175	2.0	$\mu\text{s}$
Storage Time		$t_s$	—	1.25	4.0	$\mu\text{s}$
Fall Time		$t_f$	—	0.60	2.0	$\mu\text{s}$
Inductive Load, Clamped (Table 1)						
Storage Time	$(I_C = 5.0\text{ A(pk)}$ , $V_{clamp} = 500\text{ Vdc}$ , $I_{B1} = 2.0\text{ A}$ , $V_{BE(off)} = 5\text{ Vdc}$ , $T_C = 100^\circ\text{C}$ )	$t_{sv}$	—	1.75	5.5	$\mu\text{s}$
Crossover Time		$t_c$	—	0.400	2.0	$\mu\text{s}$
Storage Time	$(I_C = 5.0\text{ A(pk)}$ , $V_{clamp} = 500\text{ Vdc}$ , $I_{B1} = 2.0\text{ A}$ , $V_{BE(off)} = 5\text{ Vdc}$ , $T_C = 25^\circ\text{C}$ )	$t_{sv}$	—	1.25	—	$\mu\text{s}$
Crossover Time		$t_c$	—	0.150	—	$\mu\text{s}$
Fall Time		$t_{fi}$	—	0.075	—	$\mu\text{s}$

(1) Pulse Test: PW - 300  $\mu\text{s}$ , Duty Cycle  $< 2\%$ .



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